

Search Notes

Application/Control No.

10/786,206

Examiner

Anish Desai

Applicant(s)/Patent under
Reexamination

SEBASTIAN ET AL.

Art Unit

1771

SEARCHED

Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Inventor search EAST	3/27/2007	APD
Text search (US PAT and USPGPUB)	3/27/2007	APD